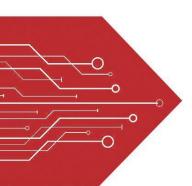
# MSKSEMI















**ESD** 

**TVS** 

**TSS** 

MOV

**GDT** 

**PLED** 

Broduct data sheet

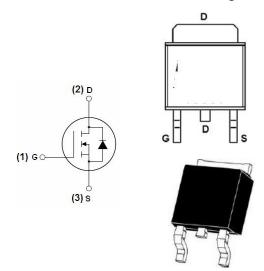
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### **Features**

● V<sub>DS</sub> = 30V,ID =90A

 $R_{DS(ON)}$ ,3.5m  $\Omega$  (Typ) @ VGS =10V

RDS(ON),  $7m \Omega (Typ) @ VGS =4.5V$ 

- Low on resistance
- Low gate charge
- Fast switching
- Low reverse transfer capacitances

#### **Application**

- DC-DC converters
- Synchronous Rectifier

#### Absolute Maximum Ratings(TA=25℃ unless otherwise noted)

Parameter	Symbol	Value	Unit				
Drain-Source Voltage	V <sub>DS</sub>	30	V				
Gate-Source Voltage		V <sub>GS</sub>	±20	V			
Drain Current-Continuous <sup>Note3</sup>	TC=25℃		90	Α			
Drain Current-Continuous	TC=100°C	- I <sub>D</sub>	63	Α			
Drain Current-Pulsed <sup>Note1</sup>	I <sub>DM</sub>	200	Α				
Avalanche Energy <sup>Note4</sup>		E <sub>AS</sub>	280	mJ			
Avalanche Current		las	33	Α			
Maximum Power Dissipation TC=25℃		P <sub>D</sub>	105	W			
Storage Temperature Range		T <sub>STG</sub>	-55 to +150	$^{\circ}\mathbb{C}$			
Operating Junction Temperature Ran	TJ	-55 to +150	°C				

#### **Thermal Resistance**

Parameter	Symbol	Min.	Тур.	Max	Unit
Thermal Resistance,Junction-to-Case	Rejc	-	3.3	-	°C/W



# Electrical Characteristics(TJ=25℃ unless otherwise noted)

OFF CHARACTERISTICS								
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V,I <sub>DS</sub> =250uA	30	-	-	٧		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	uA		
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA		

ON CHARACTERISTICS								
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit		
Gate Threshold Voltage	VGS(TH)	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>DS</sub> =250uA	1.0	1.7	2.5	٧		
Drain-Source On-State Resistance	RDS(ON)	V <sub>GS</sub> =10V,I <sub>DS</sub> =30A	-	3.5	5.5	m <b>Ω</b>		
	, ,	V <sub>GS</sub> =4.5V,I <sub>DS</sub> =20A	-	7	8.9			

DYNAMIC CHARACTERISTICS							
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
Input Capacitance	C <sub>iSS</sub>	VD0 45V V00 0V	-	1963	-		
Output Capacitance	Coss	VDS =15V, VGS = 0V,	-	248	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	f=1MHz	-	221	-		
Gate Resisitance	Rg	VDD=0V,VGS=1V, F=1MHz	-	1.43	-	Ω	

SWITCHING CHARACTERISTICS								
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit		
Turn-On Delay Time	T <sub>d(on)</sub>	\/ -40\/\/ -45\/	-	55	-			
Rise Time	t <sub>r</sub>	$V_{GS}=10V, V_{DS}=15V,$ $R_{GEN}=3\Omega I_{D}=20A$	-	36.4	-			
Turn-Off Delay Time	T <sub>d(off)</sub>	RGEN-311 ID=20A	-	37.5	-	ns		
Fall Time	t <sub>f</sub>		-	14	-			
Total Gate Charge at 10V	Qg	\/ -45\/  -45 A	-	41	-			
Gate to Source Gate Charge	Q <sub>gs</sub>	V <sub>DS</sub> =15V,I <sub>DS</sub> =45A, V <sub>GS</sub> =10V	-	6.4	-	nC		
Gate to Drain"Miller"Charge	Q <sub>gd</sub>	v GS-10 V	-	11	-			

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS									
Parameter Symbol Conditions Min. Typ. Max. Unit									
Drain-Source Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>DS</sub> =20A	-	-	1.2	V			
Reverse Recovery Time	t <sub>rr</sub>	TJ=25℃,IF=20A	-	21.7	-	nS			
Reverse Recovery Charge	Qrr	di/dt=100A/us	-	7.2	-	nC			

#### Notes:

- 1: Repetitive rating, pulse width limited by maximum junction temperature.
- 2: Surface mounted on FR4 Board, t≤10sec.
- 3: Pulse width  $\leq$  300 $\mu$ s, duty cycle  $\leq$  2%.
- 4: EAS condition: L=0.5mH,VDD=15V,VG=10V,V $_{GATE}$ =30V,Start T $_{J}$ =25  $^{\circ}$ C.

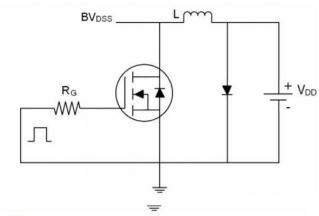
Compiance



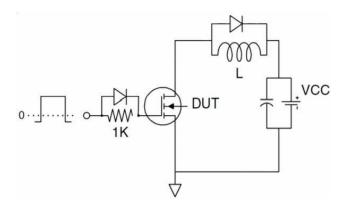


# **Test Circuit**

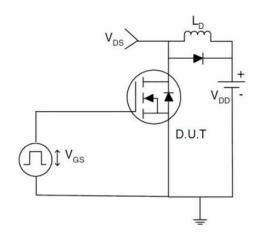
#### 1) E<sub>AS</sub> Test Circuit



#### 2) Gate Charge Test Circuit



#### 3) Switch Time Test Circuit



MS100N03



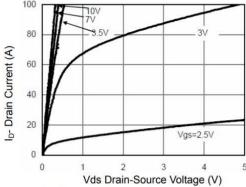


Figure 1 Output Characteristics

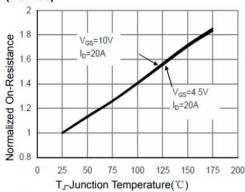
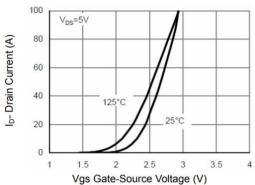


Figure 4 Rdson-Junction Temperature



**Figure 2 Transfer Characteristics** 

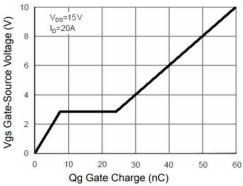


Figure 5 Gate Charge

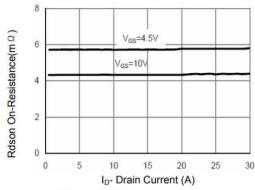


Figure 3 Rdson- Drain Current

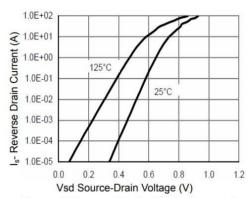
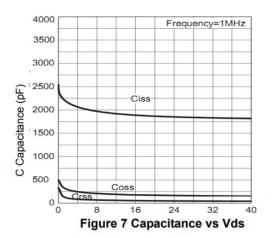


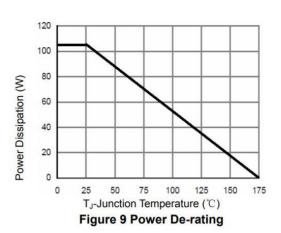
Figure 6 Source- Drain Diode Forward

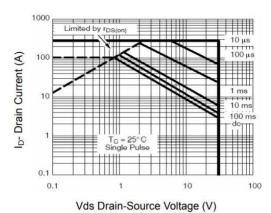


MS100N03









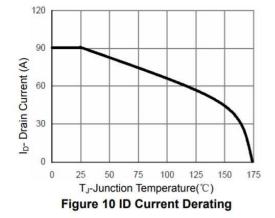


Figure 8 Safe Operation Area

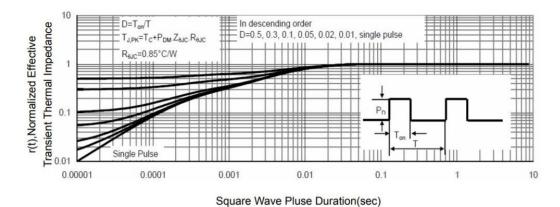
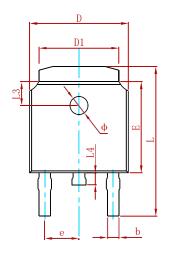


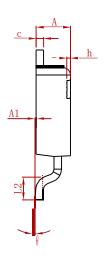
Figure 11 Normalized Maximum Transient Thermal Impedance

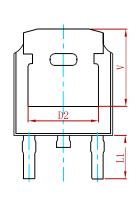






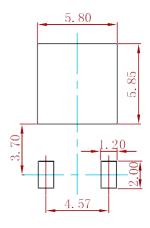






0	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.83	REF.	0.190	REF.
Е	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.712	10.312	0.382	0.406
L1	2.90	REF.	0.114	REF.
L2	1.400	1.700	0.055	0.067
L3	1.60	REF.	0.063	REF.
L4	0.600	1.000	0.024	0.039
Ф	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.25	REF.	0.207	REF.

# **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
MS100N03	TO-252	2500



Semiconductor

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